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T.H. Kim

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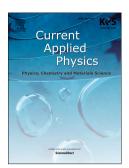
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Electric-field-induced Evolution of Domain Shapes in Polarization

Reversal of BiFeO₃ (111) Capacitors

T. H. Kim^{a,}*

^aDepartment of Physics, University of Ulsan, Ulsan 44610, Republic of Korea

*Electronic mail: thkim79@ulsan.ac.kr

Abstract

Relying on an external electric field, the shape of propagating domains evolves in

polarization switching of ferroelectric BiFeO₃ (111) capacitors. With an increasing negative

switching bias, it is shown that the domain pattern during ferroelectric domain growth

evolves from a circular shape to a dendrite-like shape. Electrical current measurements for

different poling states reveal that holes are easily injected through the BiFeO₃/SrRuO₃

interface under a negative voltage bias. It is found that holes injected by large negative-

switching-pulse fields facilitate domain nucleation in BiFeO₃ (111) films and thereby, the

promoted domain nucleation drives the shape of switched domains to be dendrite-like.

Keywords: Ferroelectrics, Polarization switching dynamics, Charge injection, Piezoresponse

force microscopy, BiFeO₃

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